Application/Control No. Applicant(s)/Patent Under Reexamination CHEN ET AL. Examiner Timothy H. Meeks Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	В	US-6,464,779	10-2002	Powell et al.	
	С	US-6,090,442	07-2000	Klaus et al.	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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